T&A-104

IN THE UNITED STATES PATENT AND TRADEMARK OFFICENTRAL FAX CENTER

In re Patent Application of

OCT 2 2 2004

H. AOKI et al

Serial No. 09/736,282

Group Art Unit: 2133

Filed: December 15, 2000

Examiner: S. CHASE

For: METHOD OF TESTING MEMORY DEVICE, METHOD OF MANUFACTURING MEMORY DEVICE, APPARATUS FOR TESTING MEMORY DEVICE, METHOD OF TESTING MEMORY MODULE, METHOD OF MANUFACTURING MEMORY MODULE, APPARATUS FOR TESTING MEMORY MODULE AND METHOD OF MANUFACTURING COMPUTER

REPLY

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

October 22, 2004

Sir:

In response to the Office Action mailed April 22, 2004, please amend the above-identified application as follows.

Serial No. 09/736,282

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IN THE TITLE OF THE INVENTION

Please amend the title to read as follows: --METHOD AND APPARATUS FOR TESTING A MEMORY DEVICE IN QUASI-OPERATING CONDITIONS --